# Torridon PCIe SFF Drive Control Modules



Hot-Swap automation for Gen3 PCIe SFF Drives



# Reduce Time to Market

Cut time to market by 20% for new products by automating manual test procedures

# **Reduce Capital Costs**

Faster and more detailed testing with Torridon means fewer test systems are required in the lab

## Reduce Human Error

Removing human intervention during tests increases consistency and results in far fewer mistakes. Test scripting provides logging and 100% repeatability

## Increase Product Reliability

Advanced techniques, such as bounds testing and fault injection provide a higher level of confidence and reduced field returns

# **Torridon Drive Control Modules:**

The industry's first automated solution for hot-swap testing. Drive Modules vastly increase the speed of testing and introduce a level of repeatability and precision that is impossible during manual tests.

## **Complete Automation:**

Any test that requires manual intervention to pull or plug a drive can now be fully automated.

## Simple Integration:

The Torridon System works with your existing automated test setup and integrate with minimal effort. A simple command set allows for easy scripting. Quarch provides full support as standard while you get started

#### Who Can Benefit?

Enclosure Manufacturers
RAID Developers
Storage System Integrators
Drive Qualification Labs
Silicon Manufacturers
Software/Driver Designers

# **Torridon PCIe SFF Drive Control Modules**

# Interface Specification

#### Power

► Supplied from Torridon
Interface Card or Array Controller

#### Comms

- USB/Serial with Interface Kit
- ➤ Telnet/USB/Serial with an Array Controller

# **Drive Compatability**

### Sizes

▶ 2.5" form factor (also compatible with 3.5" drives)

#### **Drive Connections**

► SFF-8639 and compatible

## Speed

▶ Up to PCle Gen 3

# **Switching**

#### **Switches**

- ▶ High Speed FETs
- High Current, Low insertion loss

## **Switched Pins**

► All precharge, power and high speed PCle data pins. Also SM\_BUS, Ref clocks, EPERST, DUALPORT\_ENABLE and IF\_DETECT.

# **Timing Specification**

#### **Timers**

▶ 6 Independent timers for multi stage hot-swap

# Timing resolution

► 1mS

## Pin-bounce resolution

▶ 10uS

#### Pin-bounce modes

- Simple duty-cycle
- User defined 100 bit pattern

## Manual Mode

► Full manual connection control for fault injection and bugged hardware generation

# Line Glitching

## **Timing**

► Glitch any line down to 50nS

## Sequences

Run glitches in sequences and PRBS patterns

# **Physical Dimensions**

#### QTL1743

- ▶ 69.1mm x 15mm
- ▶ Drive offset by ~14mm

# Support and Utilities

Phone and email support direct to the engineers as standard

'TestMonkey' GUI for rapid test prototyping, script generation and bench testing

# **Ordering Information**

#### QTL1743

## Single units

- ► Ideal for bench testing, debugging and evaluation
- ▶ Order with Torridon Interface Kit QTL1260

## Multiple units

► Use with Torridon Array Controller (QTL1079, QTL1461) for synchronized testing of disk arrays

# **Quarch Technology Ltd**

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